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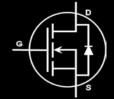




## **EPC2001 – Enhancement Mode Power Transistor**

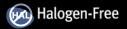
 $V_{DSS}$ , 100 V  $R_{DS(0N)}$ , 7 m $\Omega$   $I_{D}$ , 25 A

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Gallium Nitride is grown on Silicon Wafers and processed using standard CMOS equipment leveraging the infrastructure that has been developed over the last 55 years. GaN's exceptionally high electron mobility and low temperature coefficient allows very low  $R_{\rm DS(ON)}$ , while its lateral device structure and majority carrier diode provide exceptionally low  $Q_{\rm G}$  and zero  $Q_{\rm RR}$ . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

	Maximum Ratings			
V	Drain-to-Source Voltage (Continuous)		V	
V <sub>DS</sub>	Drain-to-Source Voltage (up to 10,000 5ms pulses at 125° C)	120	V	
I <sub>D</sub>	Continuous ( $T_A = 25^{\circ}C, \theta_{JA} = 13$ )	25	А	
	Pulsed (25°C, Tpulse = 300 μs)	100		
V	Gate-to-Source Voltage	6	V	
$V_{GS}$	Gate-to-Source Voltage	-5	V	
Tı	Operating Temperature	-40 to 125	°C	
$T_{STG}$	Storage Temperature	-40 to 150		



EPC2001 eGaN® FETs are supplied only in passivated die form with solder bars

#### **Applications**

- High Speed DC-DC conversion
- · Class D Audio
- Hard Switched and High Frequency Circuits

#### **Benefits**

- Ultra High Efficiency
- Ultra Low R<sub>DS(on)</sub>
- Ultra low Q<sub>G</sub>
- · Ultra small footprint

PARAMETER		TEST CONDITIONS	MIN	ТҮР	MAX	UNIT	
Static Character	Static Characteristics (T <sub>J</sub> = 25°C unless otherwise stated)						
BV <sub>DSS</sub>	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 300 \mu\text{A}$	100			V	
I <sub>DSS</sub>	Drain Source Leakage	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$		100	250	μΑ	
	Gate-Source Forward Leakage	$V_{GS} = 5 V$		1	5	mA	
I <sub>GSS</sub>	Gate-Source Reverse Leakage	$V_{GS} = -5 \text{ V}$		0.2	1		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 5 \text{ mA}$	0.7	1.4	2.5	V	
R <sub>DS(ON)</sub>	Drain-Source On Resistance	$V_{GS} = 5 \text{ V, } I_D = 25 \text{ A}$		5.6	7	mΩ	
Source-Drain Ch	Source-Drain Characteristics (T <sub>j</sub> = 25°C unless otherwise stated)						
V	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}, T = 25^{\circ}\text{C}$		1.75		V	
$V_{\text{SD}}$		$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}, T = 125^{\circ}\text{C}$		1.8		]	

All measurements were done with substrate shorted to source.

Thermal Characteristics				
		TYP		
$R_{ heta$ JC	Thermal Resistance, Junction to Case	2.1	°C/W	
$R_{\theta JB}$	Thermal Resistance, Junction to Board	15	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	54	°C/W	

Note 1:  $R_{\text{slA}}$  is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See http://epc-co.com/epc/documents/product-training/Appnote\_Thermal\_Performance\_of\_eGaN\_FETs.pdf for details.

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Dynamic Chara	<b>Dynamic Characteristics</b> (T <sub>J</sub> = 25°C unless otherwise stated)					
C <sub>ISS</sub>	Input Capacitance			850	950	
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		450	525	рF
C <sub>RSS</sub>	Reverse Transfer Capacitance			20	30	
$Q_{G}$	Total Gate Charge (V <sub>GS</sub> = 5 V)			8	10	
$Q_{GD}$	Gate to Drain Charge	$V_{DS} = 50 \text{ V}, I_D = 25 \text{ A}$		2.2	2.7	
$Q_{GS}$	Gate to Source Charge			2.3	2.8	nC
Q <sub>oss</sub>	Output Charge	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		35	40	
$Q_{RR}$	Source-Drain Recovery Charge			0	0	

All measurements were done with substrate shorted to source.

Figure 1: Typical Output Characteristics

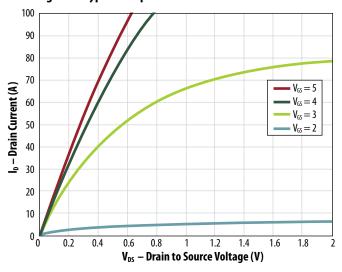


Figure 2: Transfer Characteristics

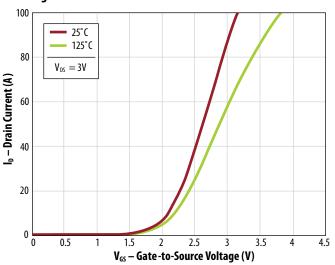


Figure 3: R<sub>DS(on)</sub> vs V<sub>GS</sub> for Various Current

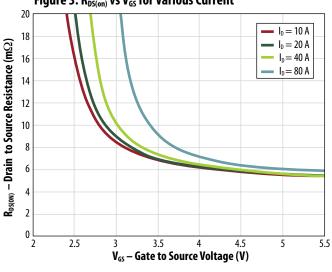
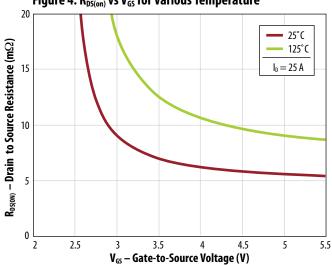
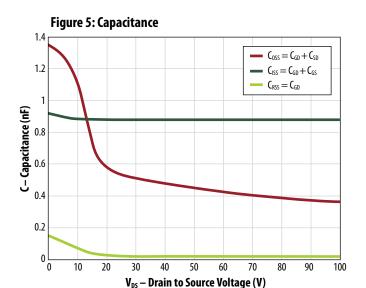
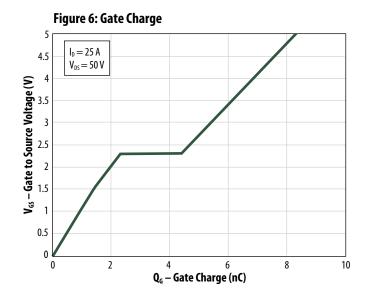
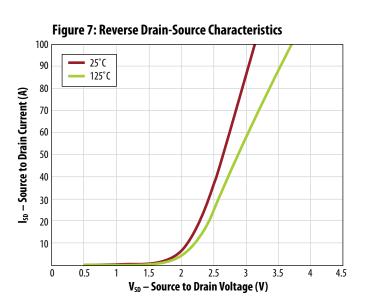


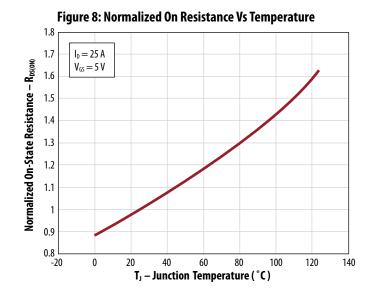
Figure 4: R<sub>DS(on)</sub> vs V<sub>GS</sub> for Various Temperature

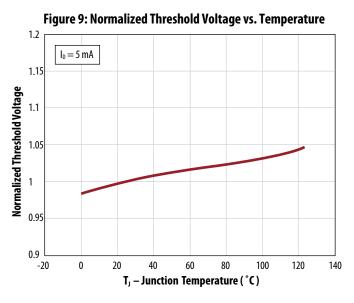


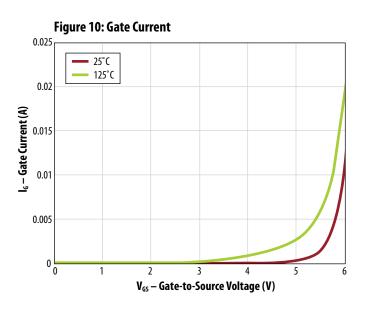






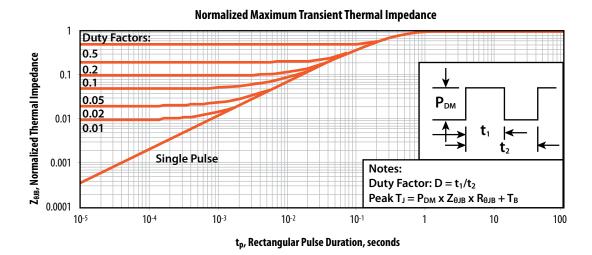






All measurements were done with substrate shortened to source.

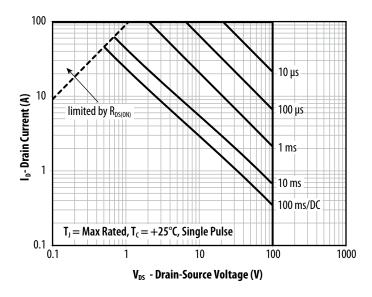
**Figure 11: Transient Thermal Response Curves** 



**Normalized Maximum Transient Thermal Impedance Duty Factors:** Z<sub>Ð.C.</sub> Normalized Thermal Impedance 0.5  $\mathbf{P}_{\mathsf{DM}}$ 0.1 0.05 0.02 0.01 0.01 Duty Factor:  $D = t_1/t_2$ Single Pulse  $Peak \, T_J = P_{DM} \, x \, Z_{\theta JC} \, x \, R_{\theta JC} + T_C$ 0.001 10-5 10-4 10-3 10-1 10-6

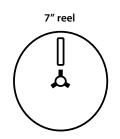
t<sub>p</sub>, Rectangular Pulse Duration, seconds

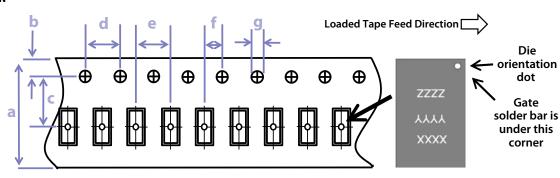
Figure 12: Safe Operating Area



#### TAPE AND REEL CONFIGURATION

4mm pitch, 12mm wide tape on 7" reel



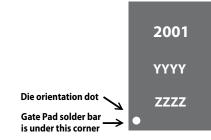


	EPC2001 (note 1)		
Dimension (mm)	target	min	max
a	12.0	11.7	12.3
b	1.75	1.65	1.85
c (note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (note 2)	2.00	1.95	2.05
g	1.5	1.5	1.6

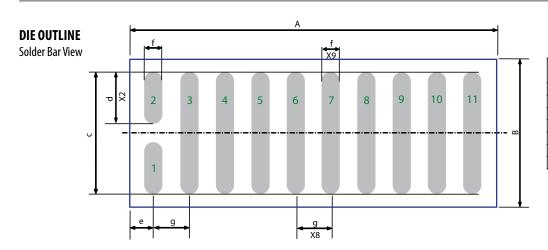
Die is placed into pocket solder bar side down (face side down)

Note 1: MSL1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard. Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

### **DIE MARKINGS**

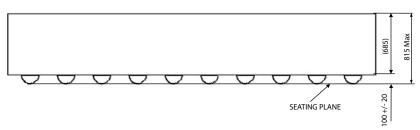


Dort		Laser Markings	
Part Number	Part # Marking Line 1	Lot_Date Code Marking line 2	Lot_Date Code Marking Line 3
EPC2001	2001	YYYY	ZZZZ



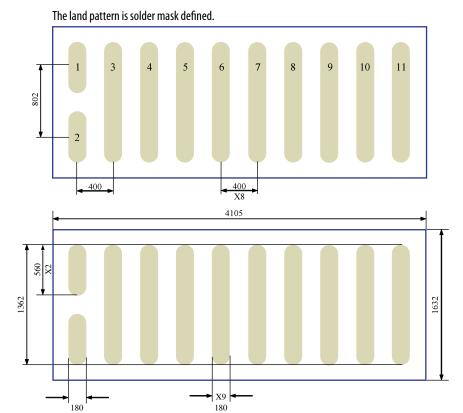
DIM	MICROMETERS				
	MIN	Nominal	MAX		
Α	4075	4105	4135		
В	1602	1632	1662		
С	1379	1382	1385		
d	577	580	583		
е	235	250	265		
f	195	200	205		
g	400	400	400		





# RECOMMENDED LAND PATTERN

(units in µm)



Pad no. 1 is Gate;

Pads no. 3, 5, 7, 9, 11 are Drain;

Pads no. 4, 6, 8, 10 are Source;

Pad no. 2 is Substrate.

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